

Search Notes

Application No.

10/033,429

Examiner

Hanh Phan

Applicant(s)

SCHULTZ ET AL.

Art Unit

2633

SEARCHED

Class	Subclass	Date	Examiner
398	180	03/16/05	HP
	186		
	185		
	138		
	154		
	155		
	163		
361	737	03/16/05	HP
	818		
	816		
174	50	03/16/05	HP
	51		
	35R		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
fast search see attached printout in the file.	03/16/05	HP
ieee search.		
jpossearch -		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner